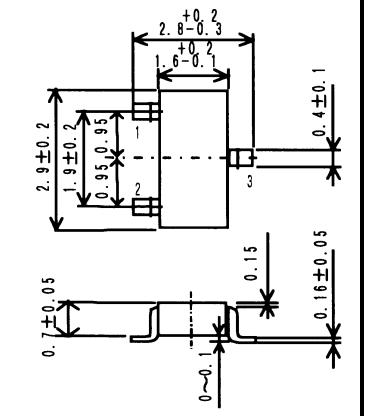
TOSHIBA Transistor Silicon NPN Epitaxial Type

# 2SC5738

High-Speed Switching Applications
DC-DC Converter Applications

- High DC current gain: $h_{FE}$ = 400 to 1000 ($I_C$ = 0.5 A)
- Low collector-emitter saturation voltage: $V_{CE\ (sat)}$ = 0.15 V (max)
- High-speed switching: $t_f$ = 90 ns (typ.)

Unit: mm




| | |
|---|---|
| JEDEC | — |
| JEITA | — |
| TOSHIBA | 2-3S1A |

Weight: 0.01 g (typ.)

## Maximum Ratings (Ta = 25°C)

| Characteristics | | Symbol | Rating | Unit |
|---|---|---|---|---|
| Collector-base voltage | | $V_{CBO}$ | 40 | V |
| Collector-emitter voltage | | $V_{CEX}$ | 30 | V |
| Collector-emitter voltage | | $V_{CEO}$ | 20 | V |
| Emitter-base voltage | | $V_{EBO}$ | 7 | V |
| Collector current | DC | $I_C$ | 3.5 | A |
| | Pulse | $I_{CP}$ | 6.0 | |
| Base current | | $I_B$ | 350 | mA |
| Collector power dissipation | DC | $P_C$ | 625 | mW |
| | t = 10 s | (Note) | 1000 | |
| Junction temperature | | $T_j$ | 150 | °C |
| Storage temperature range | | $T_{stg}$ | −55 to 150 | °C |

Note: Mounted on an FR4 board (glass epoxy, 1.6 mm thick, Cu area: 645 $mm^2$)

## Electrical Characteristics (Ta = 25°C)

| Characteristics | | Symbol | Test Condition | Min | Typ. | Max | Unit |
|---|---|---|---|---|---|---|---|
| Collector cut-off current | | $I_{CBO}$ | $V_{CB}$ = 40 V, $I_E$ = 0 | — | — | 100 | nA |
| Emitter cut-off current | | $I_{EBO}$ | $V_{EB}$ = 7 V, $I_C$ = 0 | — | — | 100 | nA |
| Collector-emitter breakdown voltage | | $V_{(BR)\ CEO}$ | $I_C$ = 10 mA, $I_B$ = 0 | 20 | — | — | V |
| DC current gain | | $h_{FE}$ (1) | $V_{CE}$ = 2 V, $I_C$ = 0.5 A | 400 | — | 1000 | |
| | | $h_{FE}$ (2) | $V_{CE}$ = 2 V, $I_C$ = 1.6 A | 200 | — | — | |
| Collector-emitter saturation voltage | | $V_{CE\ (sat)}$ | $I_C$ = 1.6 A, $I_B$ = 32 mA | — | — | 0.15 | V |
| Base-emitter saturation voltage | | $V_{BE\ (sat)}$ | $I_C$ = 1.6 A, $I_B$ = 32 mA | — | — | 1.10 | V |
| Collector output capacitance | | $C_{ob}$ | $V_{CB}$ = 10 V, $I_E$ = 0, f = 1 MHz | — | 18 | — | pF |
| Switching time | Rise time | $t_r$ | See Figure 1. | — | 100 | — | ns |
| | Storage time | $t_{stg}$ | $V_{CC} \simeq$ 12 V, $R_L$ = 7.5 Ω | — | 350 | — | |
| | Fall time | $t_f$ | $I_{B1} = -I_{B2}$ = 53 mA | — | 90 | — | |

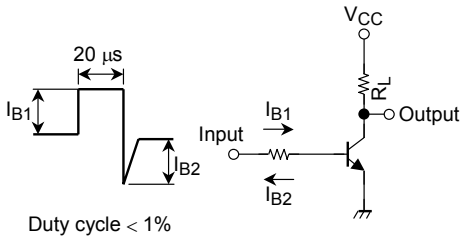
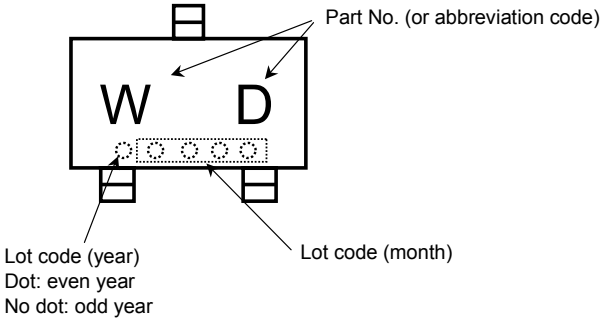
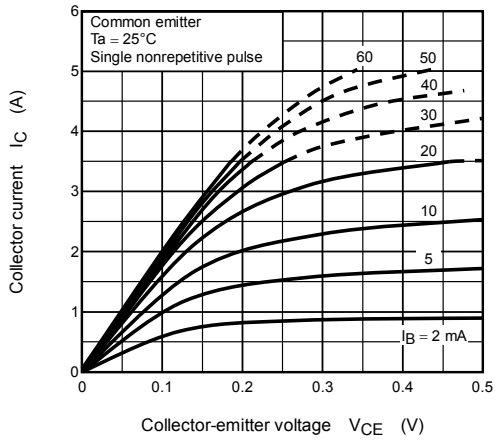



**Figure 1 Switching Time Test Circuit & Timing Chart**

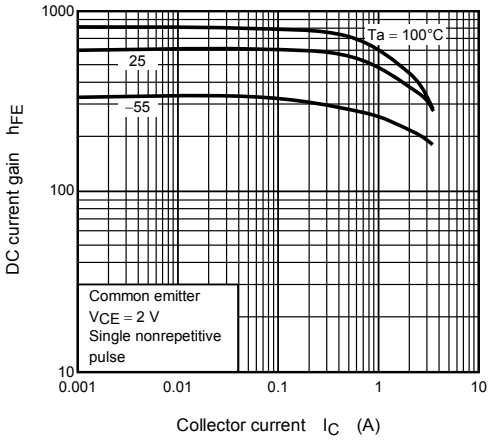
**Marking**



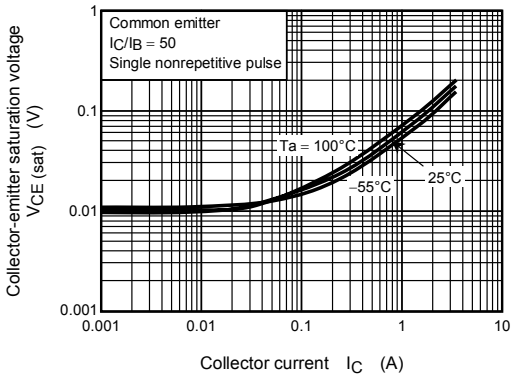
$I_C - V_{CE}$



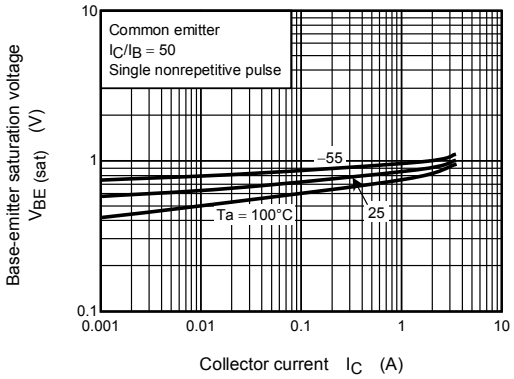

$h_{FE} - I_C$



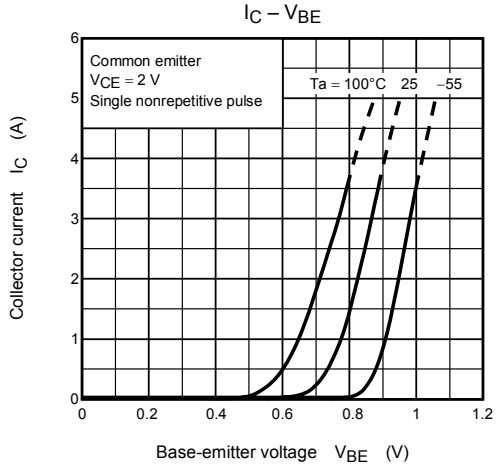

$V_{CE\ (sat)} - I_C$



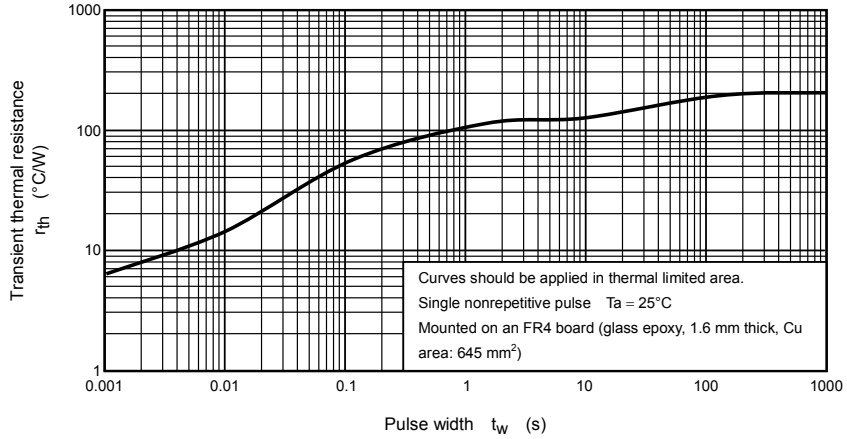

$V_{BE\ (sat)} - I_C$



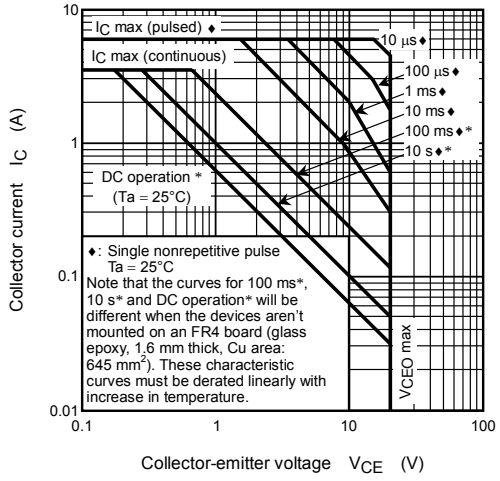

$I_C - V_{BE}$



Transient Thermal Resistance $r_{th} - t_w$




Safe Operating Area



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